(Selected Novel Technologies for Licensing							
	Innova	ative Technologies						
	Material	 Barnacle mimetic - fascinating underwater adhesion LUCID: A simple and versatile technique for tissue optical clearing Advanced Polymer Materials via Sophisticated Structural Control Highly Bright Mechanoluminescence Material Commercialization Challenges in Graphene and Carbon Nanotube Fields 						
	Electronic Device	 SiNx - Passivated Single-Electron Transistors Having Top-Gate Electrodes Energy Efficient Power Gating Architecture using NV-SRAM & NV-FF Semiconductor Structure provided with AION film on top of Ge layer 						
	Optical Device	 A micrometre-scale Raman silicon laser with a microwatt threshold Novel Terahertz Polarizer for Extremely High Extinction Ratio 						
	Spin Device	 Spin Motor and Spin Rotary Member Spin transistor utilizing Rashba SO interaction 						
	Sensor	•High Performance Magnetic Coating						
	Measurement Equipment	 Infrared Detector of single-photon sensitivity Radiation Detector using Low-Dimensional Semiconducting Scintillator Measuring Properties of an object with Acoustically Induced Electromagnetic Waves (ASEM) 						
	Cryogenics	·Helium Circulation System (HCS) for MEG						
	Energy	 • 3.8V Earth-Abundant Sodium Battery Electrode • Thermochemical Fuel Production by Non-Stoichiometric Perovskites 						
	Water	•Safety Disinfection Technique by Plasma Treated Water						
	Japan	Science and Technology Agency						



LUCID: A simple and versatile technique for tissue optical clearing

1. Abstract

- For 3D-imaging of tissue structure, a simple and versatile method that turns organs transparent benefits every biological research field.
- We present a new tissue clearing technique, LUCID (ilLUminate Cleared organs to IDentify target molecules), which does not need a delipidation process or a special device.
- LUCID is a safe, simple, and versatile tool for 3D-visualization of target molecules in every research field including cancer, bone diseases, joint diseases, leukemia, hematopoiesis, and drug discovery.

2. Procedure

- 1. Organs are simply immersed in Solution-1 (thiodiethanol+sucrose) for 0.5 to 1 day followed by Solution-2 (thiodiethanol + glycerol + non-ionic organic iodine compound) for 1 to 5 days.
- (2) LUCID-cleared samples are observed with a multiphoton microscope.
- (3) Cleared samples can be further examined with routine histochemical analyses.

Adult rat muscle

Adult rat muscle

are visible.

multiphoton microscopy

Sarcomere stripes in muscles

3. LUCID-cleared organs (macroscopic and multiphoton microscopic images)





Adult rat kidney



Renal cortex multiphoton microscopy rendered image red=blood vessel, green=renal tubule blue=SHG (collagen fiber)

3 day-old rat pup head



Adult rat brain (hippocampus) blood vessels

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Patent No. : WO2014/115206 JST/ IP Management & Licensing Group : phone: +81-3-5214-8486, e-mail: license@jst.go.jp

Ad



Adult EGFP transgenic rat hindlimb (knee joint). Femur and tibia bones become transparent and bone marrow (red color because of hemoglobin) is clearly visualized.





Tumor cells expressing EGFP (green) and blood vessels (DyLight594-bound Lycopersicon esculentum lectin, red) are visualized. Tumor structures are visualized to the limit of the working distance of our objective lens.



Ink jet media

Water soluble (or soluble in solvent) Water insoluble (or attaching to particle)

Prepared by LRP

http://www.softicons.com/web-icons/bees-help-icons-by-artbees/green-capsule-ns-icon Micelle in water Drug delivery system

Phase separation

Drug

Pigment dispersion in water Dainichiseika Color & Chemicals Mfg. Co., Ltd

Patent Licensing Available

Patent No.: WO2008/139980, WO2009/136510, WO2010/027093, WO2010/140372, WO2011/016166, etc. Kyoto University / Licensing Dept. Phone: +81-75-753-5529, E-mail: ip-eng@saci.kyoto-u.ac.jp

Highly Bright Mechanoluminescence Material Material (Optical)

Chao-Nan Xu (National Institute of Advanced Industrial Science and Technology)

1. Abstract:

The weak brightness and the attenuation of the light by the repetitive stress application were big issues, but the following mechanoluminescence materials have solved such issues and the practical examinations have been carried out.

Materials:

- (1) $xM^{1}A^{1}(1-x)M^{2}A^{2}$ (0<x<1)
 - M¹,M² = {Zn,Mn,Cd,Cu,Eu,Fe,Co,Ni,Mg,Ca} A¹,A² = Chalcogen ={O, S, Te}
- (2) SrAl₂O4:Eu²⁺ (Stuffed Tridymite Type)

2. Structure of the Material

■ xM¹A¹ · (1-x)M²A² : Mixture of { M¹A¹ :wurtzite} and





zinc-blende type

Direct Visualization of the Stress Distribution by the Mechanoluminescence



Application of the compression load to the disk sample coated with a stress illuminant



Stress distribution image via the luminescence

Luminescence intensity					
Sample	Composition	Relative luminescence intensity	Crystal grain diameter (nm)		
Control	SrAl ₂ O ₄ :Eu	100	50		
Example 1	0.99ZnCuS · 0.01MnS	3124000	10		
Example 2	0.9ZnTe · 0.1MnTe	1999000	12		
Example 3	0.9ZnCuS · 0.1MnS	51300	32		
Example 4	0.9ZnTe · 0.1CdSe	4600	25		
Example 5	0.9CdS · 0.1MnS	298	30		
Example 6	0.9CdSe · 0.1MnTe	980	50		
Example 7	0.9ZnS · 0.1MnS	869000	20		
Example 8	0.1ZnS · 0.9MnS	5800	500		
Example 9	0.9ZnSe · 0.1CdTe	6700	60		
Example 10	0.8ZnO · 0.2MnCuS	1880	15		

Learning and a second a distance of the



4. Application Example

Visualization of the crack growth in the concrete floor board of the bridge by the stress detect mechanoluminescence sheets (SrAl₂O4:Eu²⁺) http://www.jst.go.jp/kisoken/crest/research/s-houkoku/04_03.pdf (Japanese)



Compare the crack in a box with the same color and positon.

- Cracks became much clearer in green box.
- New crack appeared in red box.

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Image in 2010/11 6 months after setting. Image in 2011/06

Patent No. : USP7297295 EP1538190 JST/ IP Management & Licensing Group Phone: +81-3-5214-8486, E-mail: license@jst.go.jp Material (Carbon)

Commercialization Challenges in Graphene and Carbon Nanotube Fields

Prof. Jun-ichi FUJITA (University of Tsukuba)

1. Background

(Market Potential)Both Graphene and Carbon Nanotube (CNT) have great potentials for several next-
generation devices, however no successful commercialization have been seen yet.(Major Obstacles)
Graphene- a lack of prominent fabrication methods of a large area and low cost graphene

Carbon Nanotube(CNT) - a lack of suitable applications and low cost fabrication methods

2. New Fabrication Method of Large-area and Stable Continuous Graphene Film

(Method I)

This method easily synthesizes a large area graphene directly on the insulated substrate. Source gas of CH_4 were decomposed and promoted to graphene growth on the substrate under the assistance of catalytic reaction with Ga vapor. The uniform coverage of the gallium vapor enables graphene growth not only on a flat surface but also on a rounded surface; like a front window of Auto, and eyeglasses.



Patent: JP5578639



(Method II)

This method is to synthesize a graphene sheet at the interface between solid amorphous carbon and liquid gallium, which exhibits as a good graphitizing catalyst for a large area graphene sheet.

Amorphous carbon film was transformed into graphite layer composed of a few layers of graphene sheet. This thin graphene film can be easily transferred into silicon substrate.



Patent: WO2010/110153



(Applications examples)

-The Large-area Graphene Film can be applied to the transparent resistor elements of the **resistive-heat defoggers/demisters**. The high thermal conductivity and optical transmittance of the Graphene could give a superior performance to the transparent resistor elements.

-The Large-area and Stable Continuous Graphene Film can be applied to **the electrode pattern** on heavy-duty/industrial use printed circuit boards i.e. LCD base circuit board, automobile electrical components.



3. Ultra Sharp Metallic Probe having 2nm distal end curvature radius

- By using the field emissions from a multi-walled carbon nanotube, which soften the bottom of the tungsten by Joule heating, and the coulomb attractions to the nanotube, which finely pulled off from the metal(i.e. tungsten) tip, an ultra sharp apex of metallic (i.e. tungsten) probe having 2nm distal end curvature radius is fabricated.
- The ultra sharp apex metallic probe has excellent durability (mechanically strong) and low contact resistance and could contribute in the field of critical nano order measurements.

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Patent: WO2008/0657790

Patent Licensing Available

Graphene Fab : WO2010/110153 and JP5578639, Metallic Probe Fab : WO2008/0657790 JST/ IP Management & Licensing Group phone:+81-3-5214-8486 e-mail: license@jst.go.jp



SiNx-Passivated Single-Electron Transistors Having Top-Gate Electrodes

Prof. Yutaka MAJIMA (Tokyo Institute of Technology)

1. Abstract

- Single-electron transistors (SETs) have been expected towards highly integrated circuits. However uniform and stable device characteristics and the possibility of large area integration, including wiring are required for their real applications.
- SiNx-passivated chemically assembled SETs were developed. With an Au top-gate electrode, the SiNx-passivated SETs showed a clear Coulomb diamond, and the gate capacitance increased 16.5-fold.

2. SiNx-Passivated SET made by Au Nanoparticles and Nanogap Electrodes

Bottom-up processes that combine the use of synthesized Au nanoparticles (NPs), electroless plating, and self-assembled processes at a very small scale (< 5 nm) for chemically assembled SETs have been established.</p>



The SiNx passivation layer was realized by catalytic chemical vapor deposition (CAT-CVD) up to a thickness of 50 nm, then top-gate electrodes were added.



(PA)

3. Experimental Results



	$(M\Omega)$	$(M\Omega)$	(aF)	(aF)	(zF)	(e)
Before SiN _x deposition	500	500	1.0	0.8		0.2
After SiN _x deposition	110	100	1.0	0.8	2.3	0.35
After top-gate electrode deposition	90	170	1.0	1.15	38	-0.07

Circuit parameters of the SET

Patent Licensing Available Patent No.: WO2013/129535 JST/ IP Management & Licensing G





Stability diagram of the device at 9K

- The use of the top-gate electrode allowed us to increase the gate capacitance 16.5-fold.
- The experimental Coulomb diamond corresponds to the ideal theoretical results.
- Au nanoparticle withstands the CAT-CVD process for SiNx passivation.
- JST/ IP Management & Licensing Group Phone: +81-3-5214-8486, E-mail: license@jst.go.jp

V, (V)

Coulomb oscillation observation

Electronic Device

Energy Efficient Power Gating Architecture using NV-SRAM & NV-FF

Associate Prof. Satoshi SUGAHARA (Tokyo Institute of Technology)

1. Abstract

- A new power-gating architecture using non-volatile SRAM (NV-SRAM) and non-volatile FF (NV-FF) circuits, called nonvolatile power-gating(NVPG), was developed.
- Pseudo-Spin metal-oxide-semiconductor field effect transistors (PS-MOSFETs) are used in the non-volatile bi-stable memory circuits.
- The proposed NVPG architecture can dramatically reduce the energy issues caused by static power dissipation in advanced CMOS logic systems.

NV-SRAM consisting of Pseudo-Spin MOSFET 2.





- The spin-transfer torque magnetic tunnel junction (MTJ) is connected to the source of the MOSFET.
- The MTJ feeds back its voltage drop to the gate, and the degree of negative feedback depends on the resistance state of the MTJ.

3. NV-SRAM operation for low power consumption







- BET (Break-Even Time): Power-shutdown time to compensate for the extra energy required to provide power gating.
- The standby power of NVPG is less than 50% of the conventional technology.
- By introducing a sleep mode, power consumption can be further reduced more than 50%.

4. BET reduction architecture



- The data in the bi-stable circuit is not stored in the NVmemory element (MTJ) when the data in the bi-stable circuit and the data in the NV-memory elements match.
 - → This architecture which reduces the number of write into MTJ makes BET greatly reduced.
 - → The energy consumption is also greatly reduced.

Patent Licensing Available

Patent No.: WO2013/172065, WO2013/172066

5. Application examples



Schematic of NVPG processor/SoC using NV-SRAM and NV-FF

- Power domain Logic circuits on a chip are partitioned into several circuitry domains. (power domains)
- The power domains are electrically separated from power-supply lines and/or ground lines by sleep transistors.
- These domains can be shut down during standby mode without losing their data by using NV-SRAM and NV-FF, and thereby highly energy-efficient power-gating can be achieved.
 - →The static power is considerably reduced even during system run-time.

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Semiconductor Structure provided with AION Film on top of Ge Layer

1. Abstract

- By forming aluminum oxynitride on the Ge (Germanium) layer, high reliability thin film as the gate insulating film of MOSFET was realized.
- High-pressure inert gas post deposition annealing (PDA) using N₂ or Ar gas dramatically improved the electrical properties of AION/Ge MIS gate stacks.

2. Ge MOSFET: Expectation, and Problems to be Solved

- Ge which has the higher carrier mobility, is a promising candidate as a channel material in the next generation of MOSFETs. In miniaturized MOSFETs, gate insulators with a high dielectric constant (high-k) are required in order to suppress the gate leakage current and the short channel effects.
- There is also a problem how good interface and insulating layer on Ge can be realized.



Gate Stack Ge-insulation film interface GeO₂ -High-k Interface **Problems:**

- Degrade carrier mobility
- Less reliability
- Variation increase

3. Scalable High-k/Ge Gate Stack Technology



- We investigated the use of aluminum oxynitride film (AION) as a gate insulating film formed on the Ge substrate. By using an AION film, a thin EOT (Equivalent Oxide Thickness) is possible.
- However, heat treatment of AION film in order to improve the quality of the AION film deteriorates the interface between Ge substrate and the AION film.

After examining the conditions under which the interface between the AION film and the Ge substrate is not degraded by heat treatment, we tried to apply highpressure N₂ post-deposition annealing (HPN PDA) in order to suppress the N₂ desorption, which was analogous to high-pressure oxidation (HPO) annealing in GeO₂/Ge stack.

- HPN PDA dramatically improves the C-V characteristics, whereas the large interface states were observed in the same gate stack as a result of atmospheric-pressure N₂ (APN) post-deposition annealing.
- HPN PDA also reduces the gate leakage current.
- HPN PDA only improves the interface in the case of thin AION/Ge.



p-Ge(100)/AI MIS capacitors in HPN PDA at 500degree for 5min.

50 atm N₂

1

500°C 5min

2

Patent Licensing Available Patent No.: WO2014/030371

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A micrometre-scale Raman Silicon Laser with a microwatt Threshold

Associate Prof. Yasushi TAKAHASHI(Osaka Prefecture University)





http://www.jst.go.jp/tt/EN/

p/tt/EN/

1. Novel Mechanism: Nano-Spin Motor

Spin Motor and Spin Rotary Member

Prof. Atsufumi HIROHATA(York University)



Patent Licensing Available Patent No. : WO2014/024697 JST/ IP Management & Licensing Group Phone: +81-3-5214-8486,

http://www.jst.go.jp/tt/EN/

Molecular selection

by centrifugal force

Motor

Magneto-Optic Effect

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Spin Device

Spin Transistor utilizing Rashba SO interaction

Assistant Prof. Makoto KOHDA (Tohoku University) 1. The newly proposed spin transisitor -Spin-Orbit Interaction : A proposed Device Structure No need for external B fields (Bex) and magnetic materials Side gated QPC V_{SGL} $\varepsilon_{SOI} = \pm \alpha k_F = \pm \frac{1}{2} g \mu_B B_{eff}$ ₩V_{TG} Effective B field $B_{eff} \propto \frac{p \times E}{2m_0 c^2}$ Cr/Au VSGR Semiconductor 2DEG B E>0 E = 0Al2O3 InGaAs Small Beff Large B 2DEG 2. Mechanism to induce Spin Polarization and Spin Rectification Effect $H = \tilde{\alpha}\vec{\sigma} \cdot (\vec{p} \times \vec{E}) + \frac{1}{2}g\mu_{B}\vec{\sigma} \cdot \vec{B}_{ex} = g\mu_{B}\vec{\sigma} \cdot \vec{B}_{eff} + \frac{1}{2}g\mu_{B}\vec{\sigma} \cdot \vec{B}_{ex}$ Side Gate Bex>0T Bex=0T Bex=0T Bex>0T Beff direction Beff direction Bex lowers down Bex raises up spin Vage spin energy level energy level above Electron Electric Electric Motion below Fermi Energy Fermi Energy. . No current generation Down spin Field Field Electron Motion generation Fermi Energy -Vsd +Vsd Spin Polarization VSGL Spin Polarization Direction and Direction and Electron Flow Electron Flow VSGR Electron Gate Electric Motion Side Gate •)Field Drain Electrode Electron Electric Au/Cr Gate Electrode(100nm) Motion Field Al2O3 Gate Insulator(150nm) Bef InAIAs Barrier Layer InGaAs 2DEG InAIAs Barrier Layer InAIAs Barrier Layer InP Substrate

Spin Polarization Mechanism



Source Electrode





Spin Polarization induced by effective magnetic field B_{eff} (The inset shows an image of a QPC channel region taken by a SEM.)

Spin Rectification Mechanism

VSGR

Maximum spin polarization is 70% at 0.5(2e²/h)



Spin Polarization at 0.5 (2e²/h) structure

Patent Licensing Available Patent No.: WO2013/027712(JP, US, EP, KR, CN) JST/ IP Management & Licensing Group Phone: +81-3-5214-8486, E-mail: license@jst.go.jp Prof. Emeritus Akihisa INOUE (Tohoku University) Prof. Emeritus Hiroyuki WAKIWAKA (Shinshu University)

1. Introduction

High performance magnetic coating is materialized by a series of patented technologiessoft magnetic glassy metal, coating of the glassy metal by thermal spraying and applications of the coating as torque sensors.

2. Key Features



Infrared Detector of single-photon sensitivity

Prof. Emeritus Susumu KOMIYAMA Group (University of Tokyo)

1. CSIP: Charge Sensitive Infrared Phototransistor

Measurement Equipment



2. Application: "passive"near-field spectroscope



3. Tabletop ultrasensitive THz detector (jointly developed with UNISOKU)



Patent Licensing Available Patent No.: WO2010/137422, WO2010/137423 JST/ IP Management & Licensing Group Phone: +81-3-5214-8486, E-mail: license@jst.go.jp



Material	Density	Emission maximum	Relative	Decay components	
	g/cm ³	nm	Sc.	ns (%)	
NaI(TI)	3.67	415	100	230 (91%), 150,000 (9%)	
BGO	7.13	480	8	60 (10%), 300 (90%)	
LSO(Ce)	7.35	420	75	41 (100%)	
stilbene	1,16	410	22	4.6 (90%), 15 (10%)	
BaF ₂ fast		220	5		
BaF ₂ slow	4.89	310	16	0.8 (20%), 630 (80%)	
C ₄ PbBr ₄	2.65	438	6.5	2.8 (40%), 18 (40%), 130 (20%)	
C.PhI.	2.40	558	n.	0.39 (30%) 3.8 (30%) 16 (40%)	

[CnH2n+1NH3]+ (n=3, 4, 6, 10, etc.) Insulating barrier layer Self-assembled multiple quantum well structure

1. Localization of Exciton

Insulating barriers prevent thermal

and their probability to meet with nonradiative centers is reduced.

2D Exciton

Insulating barrier

Semiconducting well layer

[2] G. C. Papavassiliou: Prog. Solid

State Chem., 25 (1997) 125-270.

diffusion of excitons by its potential.

2. Suppression of Thermal Quenching by Quantum Confinement Structure

e wavefunction

3D Exciton Nonradiative center

semiconductor [2]

Shallow trapping site

2. Thermal Stabilization of

electron and hole wavefunctions is

enlarged, the binding energy of a 2D-EXCITON becomes 4 time larger than that of a 3D-exciton in the bulk

Because the overlapping region of the

Exciton Level

h⁺ wavefunction



Thermal Quenching Processes

3. Properties of the New Scintilator

Scintillation Spectra of the Bromide and lodide



Scintillation Time Profile of the lodide

Mechanism to suppress Thermal Quenching

by quantum confinement structures



Time / nanosecond

Patent Licensing Available Patent No.: WO2002/056056 (JP, US, EP) JST/ IP Management & Licensing Group Phone: +81-3-5214-8486, E-mail: license@jst.go.jp http://www.jst.go.jp/tt/EN/

Measurement Equipment

Properties

Galistone

Measuring Properties of an object with Acoustically Induced Electromagnetic Waves(ASEM)

Associate Prof. Kenji IKUSHIMA (Tokyo University of Agriculture and Technology)

1. Novel ASEM method



(developed by K. Ikushima)

2. Measurement & Data

Electromagnetic radiation is generated by temporal modulation of the magnetization or electric polarization via ultrasonic waves in a variety of materials.





4. Application

 Imaging of materials which electromagnetically responds via the ultrasonic wave. (piezoelectric, magnetic materials which light doesn't penetrate)

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Patent No.: WO2007/055057 (JP, US, EP) JST/ IP Management & Licensing Group Phone: +81-3-5214-8486, E-mail: license@jst.go.jp

Helium Circulation System (HCS) for MEG Cryogenics

Prof. Emeritus Tsunehiro TAKEDA (University of Tokyo) 1. Helium Problems and MEG (Magnetoencephalography) MEG problems HELIUM SALES ON THE RISE Large amount of expensive He required m from the US federal reserve in Amarillo, Texas. After buildir on in 1996 required the nation to sell off its helium stockpile. erve in the 1960s, le SUPPLY AND DEMAND (8 - 10l/day) 25 Production **Frequent liquid He refilling required** OF HELIUM BY VOLUME - Shipments year) 17% (2 times/week) 8% 15

Required specifications for the **HCS for the MEG**

Liquid He circulation: 10l/day Continuous Operation: 1 year or more

•No blocking by contaminants (H₂O, N₂, O₂)

No incremental noise

(acoustic/ magnetic) added by HCS





Current Status of Helium production and consumption (excerpt from Nature, 31 May 2012, Vol 485)

2. Newly developed Helium Circulation System K-GM Cry



Basic idea of the new HCS

- A: pipe to lead LHe (to cool SQUIDs) from condenser to dewar by gravity
- B: pipe to lead lower temperature (4K) HeG from dewar to condenser
- C: pipe to circulate higher temperature (40K) HeG (to cool the dewar)

D: pipe to add pure HeG

EV: electric valve

- MFC: mass flow controller
- Line B ⇒ A
- The condenser absorbs low temperature gas and liquefies it without raising it up to the room temperature (300K). -Line $D \Rightarrow C$
- 40K HeG is flowed into the neck tube of the dewar to cool it.



1) 4K HeG : naturally circulated by liquefaction in the condenser

- 2) 40K HeG (to cool dewar) : circulated by a pump
- Refiner with heater is introduced to prevent blocking by contaminants (H₂O, N₂, O₂).
- Trapped contaminants are automatically exhausted after evaporated by the heater.

Transfer tube : a newly developed seven concentric TT to reduce the amount of heat flowing into the system Block diagram of the gas flow



BEFORE HCS installation (b)AFTER HCS installation Noise amplitude spectra of selected 10 channels of the system Advantages:

1)Helium consumption: reduced to 1/200 of conventional systems.

Multi-pipe TT of the HCS installed on the commercialized MEG

4. Applications in other fields



Patent Licensing Available

3)Incremental noise: no noticeable noise added by HCS This system is already commercialized by Frontier Technology Institute Inc. (JAPAN)

2)Operation cost: less than 1/10 of conventional systems.

Patent No.: WO2000/039513, WO2004/070296, WO2004/110269 JST/ IP Management & Licensing Group Phone: +81-3-5214-8486, E-mail: license@jst.go.jp

3. HCS and MEG in Operation



Prof. Atuo YAMADA (University of Tokyo)

- We discovered a novel cathode Na₂Fe₂(SO₄)₃ for rare-metal-free Na-ion rechargeable battery.
- Na₂Fe₂(SO₄)₃ cathode shows the highest-ever Fe³⁺/Fe²⁺ redox potential at 3.8 V (versus Na) with more than 100mAh/g.
- Na₂Fe₂(SO₄)₃ has a fast (liquid-like) Na transport channel during the charge-discharge reaction.

5

C/20 25°C

1. Novel Na₂Fe₂(SO₄)₃ Electrode

- Overall comparison of the Fe-based cathode materials in Na-ion battery system
- Na₂Fe₂(SO₄)₃ provides ; redox potential : 3.8V (versus Na/Na+) current density : >100mAh/g energy density : >400Wh/kg (theoretical 540Wh/kg)
- The theoretical capacity is higher than those of Li cathodes for present Li battery system.
- It is a entirely new composition and structure with the first alluaudite-type sulphate framework.



2. Electrode Properties of Na₂Fe₂(SO₄)₃ in Na Cell

- Galvanostatic charging and discharging profiles of Na_{2-x}Fe₂(SO₄)₃ cathode cycled between 2.0 and 4.5V at 25°C
- The initial capacity of 102 mAh/g (theoretical 120mAh/g) is highly reversible over 30 cycles under various current rates C/20(2Na in 20h) to 20C(2Na in 3min).

3. Na-ion Diffudion in Na₂Fe₂(SO₄)₃

- Ab initio calculations show very low activation energies for Na-ion migration within Na3 channel (Ea=0.14eV; Liquid-like) and Na2 channel(Ea=0.27eV).
- These Na channels show very fast charge-discharge kinetics, and the continuous space of Na3 site acts as a faster Na transport channel.



1st cycle

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Patent No. : PCT/JP2014/073162

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Thermochemical Fuel Production by Non-Stoichiometric Perovskites

Prof. Yoshihiro YAMAZAKI (Kyushu University)

1. Thermochemical fuel production

Energy









2. Physicochemical Property of Plasma Treated Water (PTW) with the Reduced pH





-85 degree C

- Reducing pH<4.7 strengthens the bactericidal activity drastically.</p>
- Mechanism
 - •Plasma generate O₂•(superoxide anion radicals).
 - •When pH is <4.8, O₂• is changed to HOO• (hydroperoxy radicals) by acid dissociation, and HOO• directly interact with bacterial cells to inactivate them.
- The presence of O₂ is essential for the bacterial inactivation.
- 3. Bactericidal Activity of Plasma Treated Water
 - The activity can be preserved for a month by freezing.
 - Safety indirect plasma disinfection will be brought by the combination of the plasma treated water and the reduced pH.



Patent Licensing Available

Patent No. : WO2008/072390,WO2009/041049

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- 1. To achieve innovation in science and technology through creative research and development.
- 2.To maximize research outcomes by managing research resources on the virtual network.
- 3. To develop the nation's infrastructure for science and technology to accelerate innovation in science and technology.

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Japan Science and Technology Agency Center for Intellectual Property Strategies

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